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ON Semiconductor®

FDMC4435BZ P-Channel Power Trench[®] MOSFET -30 V, -18 A, 20 m Ω

Features

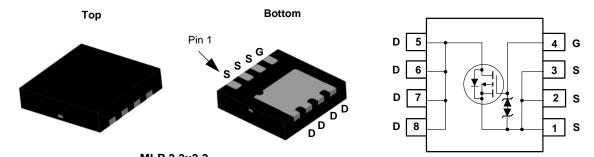
- Max $r_{DS(on)}$ = 20 m Ω at V_{GS} = -10 V, I_D = -8.5 A
- Max $r_{DS(on)}$ = 37 m Ω at V_{GS} = -4.5 V, I_D = -6.3 A
- Extended V_{GSS} range (-25 V) for battery applications
- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability
- HBM ESD protection level >7 kV typical (Note 4)
- 100% UIL Tested
- Termination is Lead-free and RoHS Compliant

General Description

This P-Channel MOSFET is produced using ON Semiconductor's advanced Power Trench[®] process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

Applications

- High side in DC DC Buck Converters
- Notebook battery power management
- Load switch in Notebook



MLP 3.3x3.3

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V _{DS}	Drain to Source Voltage			-30	V	
V _{GS}	Gate to Source Voltage			±25	V	
	Drain Current -Continuous	T _C = 25 °C		-18		
I _D	-Continuous	T _A = 25 °C	(Note 1a)	-8.5	Α	
	-Pulsed			-50		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	32	mJ	
P _D	Power Dissipation	T _C = 25 °C		31	w	
	Power Dissipation	T _A = 25 °C	(Note 1a)	2.3	vv	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case		4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	53	C/VV

Package Marking and Ordering Information

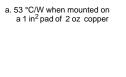
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC4435BZ	FDMC4435BZ	MLP 3.3X3.3	13 "	12 mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = -250 μA, V _{GS} = 0 V	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A}$, referenced to 25 °C		21		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V},$ $V_{GS} = 0 \text{ V},$ $T_{J} = 125 \text{ °C}$			-1 -100	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μA
On Chara	acteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = -250 μA	-1.0	-1.8	-3.0	V
$\Delta V_{GS(th)}$ ΔT_{J}	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A}$, referenced to 25 °C		-5		mV/°C
J		V _{GS} = -10 V, I _D = -8.5 A		14	20	mΩ
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -6.3 \text{ A}$		21	37	
		V _{GS} = -10 V, I _D = -8.5 A, T _J = 125 °C		20	29	- 11152
9fs	Forward Transconductance	$V_{DD} = -5 V, I_D = -8.5 A$		25		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance			1535	2040	pF
C _{oss}	Output Capacitance	−V _{DS} = -15 V, V _{GS} = 0 V, _ f = 1 MHz		310	410	pF
C _{rss}	Reverse Transfer Capacitance			280	420	pF
R _g	Gate Resistance	f = 1 MHz		4		Ω
Switching	g Characteristics					
t _{d(on)}	Turn-On Delay Time			10	20	ns
G (OD)				9	18	ns
t _r	Rise Time	V _D = -15 V, I _D = -8.5 A,		0		
t _r	Rise Time Turn-Off Delay Time	V_{DD} = -15 V, I _D = -8.5 A, V _{GS} = -10 V, R _{GEN} = 6 Ω		35	56	ns
				-	-	ns ns
t _r t _{d(off)} t _f	Turn-Off Delay Time			35	56	
t _r t _{d(off)} t _f Q _g	Turn-Off Delay Time Fall Time	$V_{GS} = -10 \text{ V}, \ \overline{R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } -10 \text{ V}$ $V_{GS} = 0 \text{ V to } -4.5 \text{ V}$ $V_{DD} = -15 \text{ V},$		35 19	56 34	ns
t _r t _{d(off)} t _f Q _g Q _g	Turn-Off Delay Time Fall Time Total Gate Charge	$V_{GS} = -10 \text{ V}, \text{R}_{\text{GEN}} = 6 \Omega$		35 19 38	56 34 53	ns nC
t _r t _{d(off)} t _f Q _g	Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge	$V_{GS} = -10 \text{ V}, \ \overline{R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } -10 \text{ V}$ $V_{GS} = 0 \text{ V to } -4.5 \text{ V}$ $V_{DD} = -15 \text{ V},$		35 19 38 20	56 34 53	ns nC nC
t _r t _{d(off)} t _f Q _g Q _g Q _{gs} Q _{gd}	Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge	$V_{GS} = -10 \text{ V}, \ \overline{R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } -10 \text{ V}$ $V_{GS} = 0 \text{ V to } -4.5 \text{ V}$ $V_{DD} = -15 \text{ V},$		35 19 38 20 4.3	56 34 53	ns nC nC nC
$\begin{array}{c} t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \end{array}$	Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge urce Diode Characteristics	$V_{GS} = -10 \text{ V}, \ \overline{R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } -10 \text{ V}$ $V_{GS} = 0 \text{ V to } -4.5 \text{ V}$ $V_{DD} = -15 \text{ V},$		35 19 38 20 4.3	56 34 53	ns nC nC nC
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$\begin{array}{c} t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \end{array}$	Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge urce Diode Characteristics	$V_{GS} = -10 \text{ V}, \ \overline{R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } -10 \text{ V}$ $V_{DD} = -15 \text{ V},$ $I_D = -8.5 \text{ A}$ $V_{GS} = 0 \text{ V}, \ I_S = -8.5 \text{ A}$ (Note 2)		35 19 38 20 4.3 11	56 34 53 28 1.5	ns nC nC nC



2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0 %.

3. Starting T_J = 25°C; P-ch: L = 1mH, I_{AS} = -8A, V_{DD} = -27V, V_{GS} = -10V.



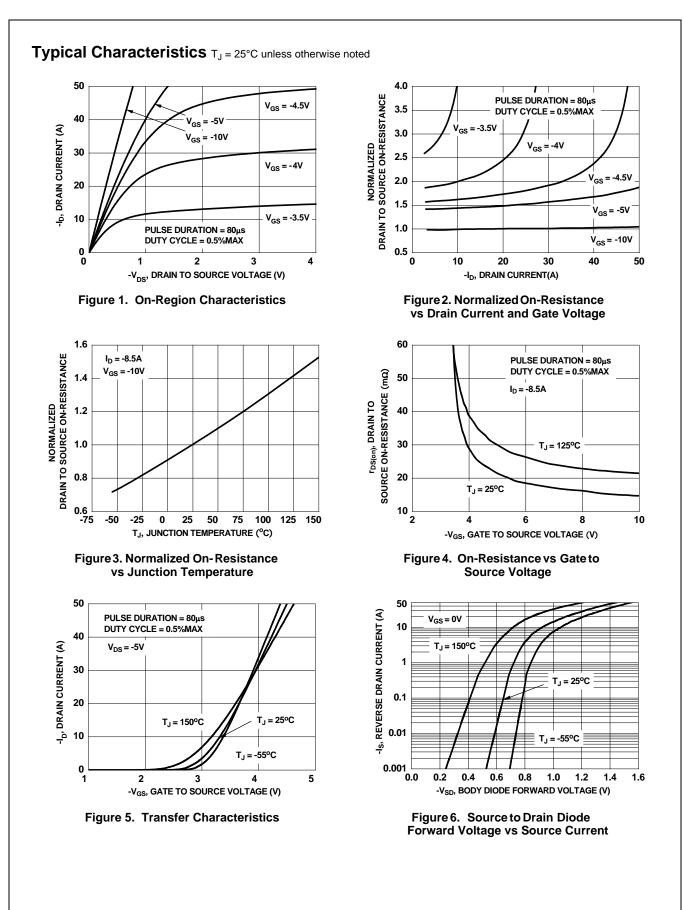
4. The diode connected between the gate and source servers only as protection against ESD. No gate overvoltage rating is implied.

b.125 °C/W when mounted on a minimum pad of 2 oz copper

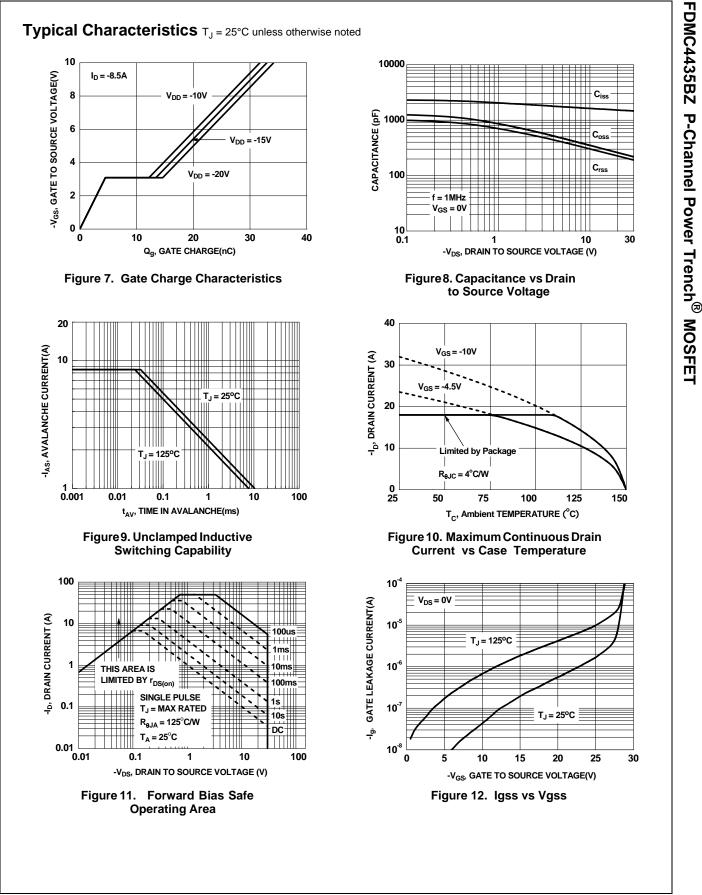
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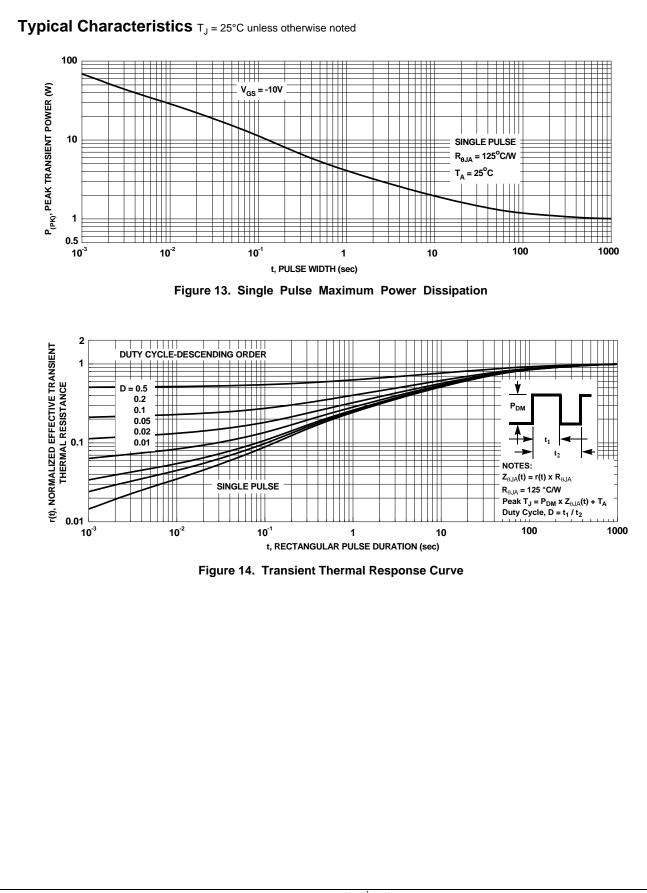
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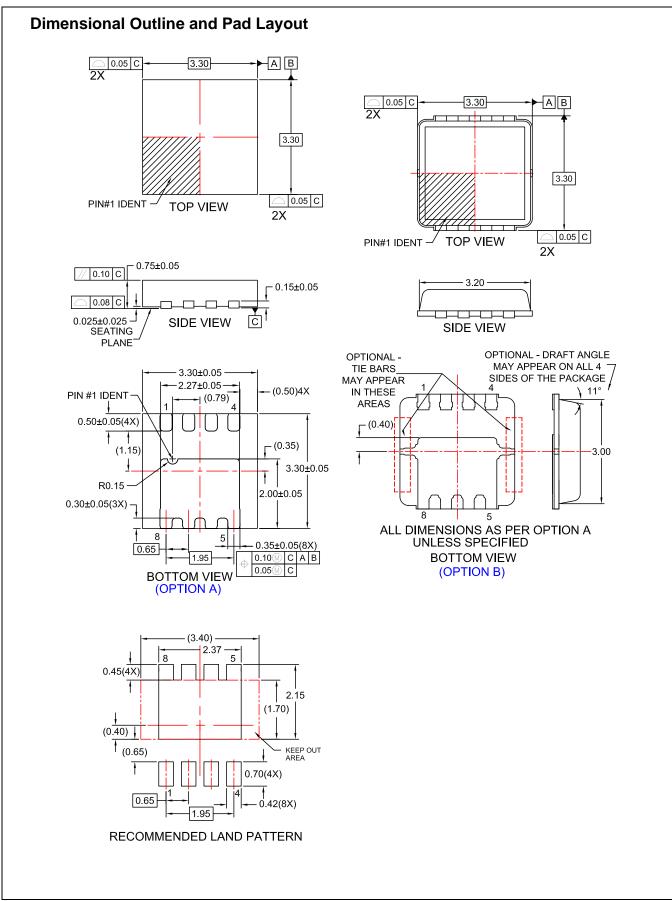
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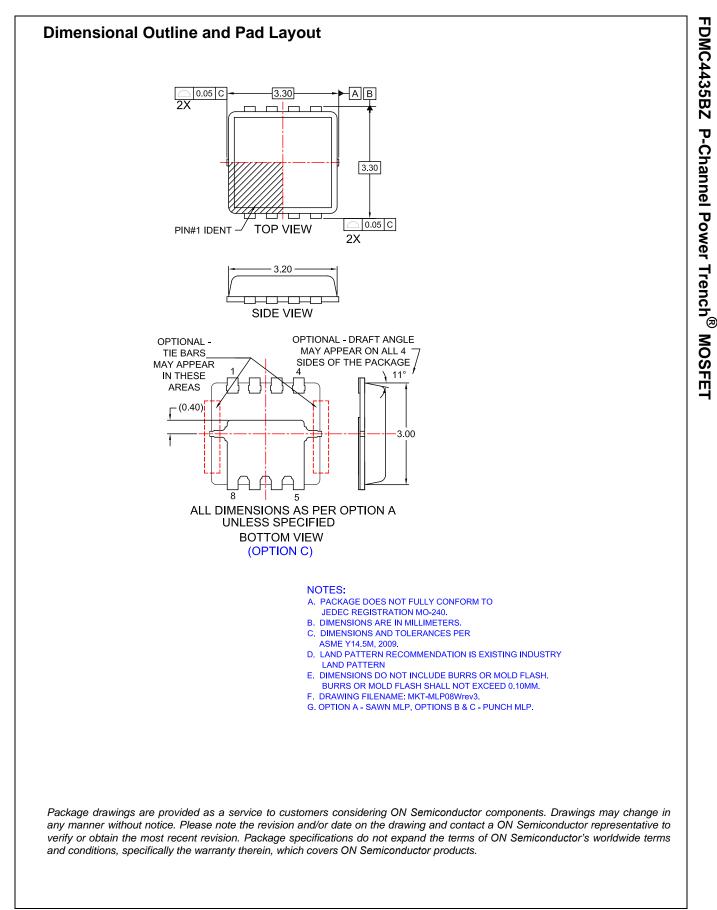
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